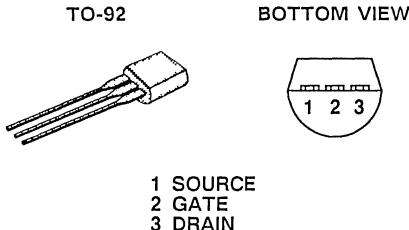


PRODUCT SUMMARY

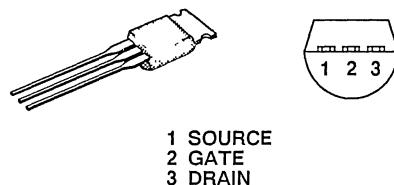
PART NUMBER	$V_{(BR)DSS}$ (V)	$r_{DS(ON)}$ (Ω)	I_D (A)	PACKAGE
VN0808L	80	4	0.30	TO-92
VN0808M	80	4	0.33	TO-237



Performance Curves: VNDQ09 (See Section 7)

TO-237

BOTTOM VIEW



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	VN0808L	VN0808M	UNITS
Drain-Source Voltage	$T_A = 25^\circ\text{C}$	V_{DS}	80	80	V
Gate-Source Voltage		V_{GS}	± 30	± 30	
Continuous Drain Current ²	$T_A = 25^\circ\text{C}$	I_D	0.30	0.33	A
	$T_A = 100^\circ\text{C}$		0.19	0.21	
Pulsed Drain Current ^{1, 2}	$T_A = 25^\circ\text{C}$	I_{DM}	1.9	1.9	W
Power Dissipation		P_D	0.8	1	
$T_A = 100^\circ\text{C}$	0.32		0.4		
Operating Junction and Storage Temperature	T_J, T_{stg}	-55 to 150			°C
Lead Temperature (1/16" from case for 10 seconds)	T_L	300			

6 THERMAL RESISTANCE

THERMAL RESISTANCE	SYMBOL	VN0808L	VN0808M	UNITS
Junction-to-Ambient	R_{thJA}	156	125	°C/W

¹Pulse width limited by maximum junction temperature

²This parameter has been revised from previous datasheet

VN0808 SERIES

Siliconix
incorporated

ELECTRICAL CHARACTERISTICS ¹			LIMITS			
PARAMETER	SYMBOL	TEST CONDITIONS	TYP ²	VN0808		UNIT
				MIN	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0 \text{ V}, I_D = 10 \mu\text{A}$	120	80		V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 1 \text{ mA}$	1.6	0.8	2	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 15 \text{ V}$	± 1		± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 80 \text{ V}$ $V_{GS} = 0 \text{ V}$ $T_J = 125^\circ\text{C}$	0.03 0.3		10 500	μA
On-State Drain Current ³	$I_{D(\text{ON})}$	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}$	1.8	1.5		A
Drain-Source On-Resistance ³	$r_{DS(\text{ON})}$	$V_{GS} = 5 \text{ V}, I_D = 0.3 \text{ A}$	4.2			
		$V_{GS} = 10 \text{ V}$ $I_D = 1 \text{ A}$ $^4 T_J = 125^\circ\text{C}$	3.6 6.8		4 8	Ω
		$V_{DS} = 10 \text{ V}, I_D = 0.5 \text{ A}$	350	170		mS
Forward Transconductance ³	g_{FS}	$V_{DS} = 10 \text{ V}, I_D = 0.1 \text{ A}$	225			μs
DYNAMIC						
Input Capacitance	C_{iss}	$V_{DS} = 25 \text{ V}$ $V_{GS} = 0 \text{ V}$ $f = 1 \text{ MHz}$	35		50	
Output Capacitance	C_{oss}		15		40	pF
Reverse Transfer Capacitance	C_{rss}		2		10	
SWITCHING						
Turn-On Time	t_{ON}	$V_{DD} = 25 \text{ V}, R_L = 23 \Omega$ $I_D = 1 \text{ A}, V_{GEN} = 10 \text{ V}$ $R_G = 25 \Omega$ (Switching time is essentially independent of operating temperature)	6		10	
Turn-Off Time	t_{OFF}		8		10	ns

- NOTES: 1. $T_A = 25^\circ\text{C}$ unless otherwise noted.
 2. For design aid only, not subject to production testing.
 3. Pulse test; $PW = 300 \mu\text{s}$, duty cycle $\leq 2\%$.
 4. This parameter has been revised from previous datasheet.